

#15/B
12/4/02

CERTIFICATION OF FACSIMILE TRANSMISSION:

I HEREBY CERTIFY THAT THIS CORRESPONDENCE IS BEING
FACSIMILE TRANSMITTED TO THE USPTO ON THE DATE SHOWN
BELOW:

Date of Transmission: December 3, 2002

Name of Person

Making Transmission: Linda L. Gray

Signature: Linda L. Gray 12/3/02

IN THE UNITED STATES PATENT AND TRADEMARK OFFICEIn Re Application of _____ :

December 3, 2002

DAVID C. AHLGREN, ET AL. _____ :

Group Art No.: 1765

Serial No. 09/633,857 _____ :

Examiner: Robert M. Kunemund

Filed: August 7, 2000 _____ :

IBM Corporation

Bldg. 300, Zip 482

2070 Route 52

Hopewell Junction, New York 12533

Title: IN-SITU MONITORING AND CONTROL
OF GERMANIUM PROFILE IN SILICON-
GERMANIUM ALLOY FILMS AND
TEMPERATURE MONITORING DURING
DEPOSITION OF SILICON FILMS _____ :

OFFICIAL

PRELIMINARY AMENDMENTAssistant Commissioner for Patents
Washington, D.C. 20231

FAX RECEIVED

DEC 04 2002

GROUP 1700

Sir:

Responsive to the Office Action dated 09/06/2002, and prior to continued
examination, kindly amend the above-identified application as follows:

FIS920000149US1

- 1 -